

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/068,159	TAN ET AL.
	<b>Examiner</b> Thao P. Le	<b>Art Unit</b> 2818

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
interference (see note)		4/27/2007	T.LE